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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/750,714	GONZALEZ ET AL.	
Examiner	Art Unit	
Benjamin P. Geib	2181	

	SEAR	CHED	
Class	Subclass	Date	Examiner
712	28	10/27/2006	BPG

INT	ERFERENC	FERENCE SEARCHED		
Class	Subclass	· Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated East Search	10/27/2006	BPG
Updated NPL Search (Google Scholar and IEEE Xplore)	10/27/2006	BPG
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